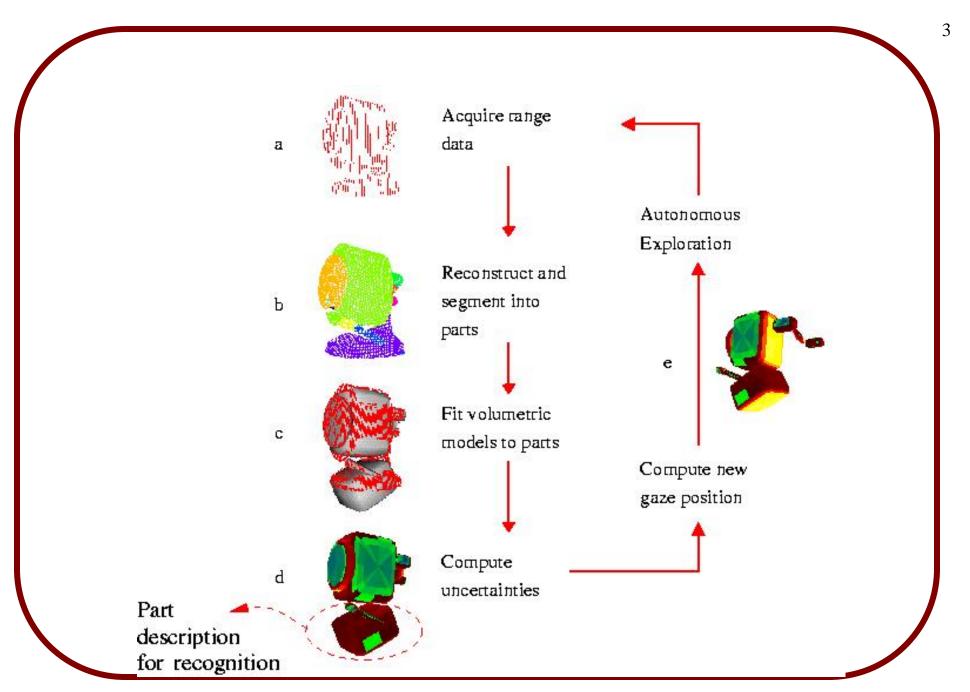
# ECSE-626 Statistical Computer Vision

**Application of Bayesian Object Recognition** 

## Recognition of 3D Models

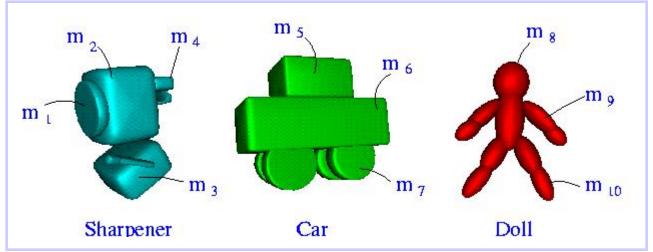
- We wish to recognize objects with complex shapes.
- Can find a single complex model to represent entire object:
  - Hard to find a general model
  - Sensitive to partial occlusion
- Alternately *recognition-by-parts*: object represented by collection of parts. Recognition based on identification of parts.



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## 3D Model Recognition

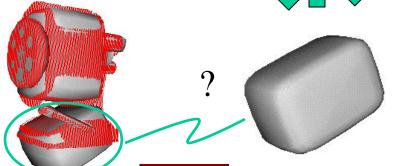
Database of object parts



Range image Parametric model







Which part does the measurement correspond to?

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## Recognition of 3D Models

- Bottom-up system described used to gather sequence of data sets (i.e. from a laser rangefinder) from an object's surface.
- Entire process, from range measurement to model fitting, referred to as *measurement* of an object.
- From a particular viewpoint, range data are gathered, segmented into parts.

## **Part Recognition**

- Define the data space, D.
- Segmented range data set for an observed part be denoted  $\mathbf{d} \in D$
- Let S be a discrete random variable representing the parts in the database which, in this case, take on a finite set of values,  $\{S_i\}|_{i=1..K}$ .

## **Part Recognition**

• The goal of the recognition strategy is to compute a discrete conditional probability density function describing the likelihood of each of the K parts in the database  $\{S_i\}|_{i=1..K}$  given the range data set  $\mathbf{d}$ :

## **Part Recognition**

• The goal of the recognition strategy is to compute a discrete conditional probability density function describing the likelihood of each of the K parts in the database  $\{S_i\}|_{i=1..K}$  given the range data set  $\mathbf{d}$ :

$$p(S_i | \mathbf{d}) |_{i = 1..K}$$

- We need to build an appropriate distribution to represent what is known about the physical theory that predicts estimates of the parameters given an object in the scene.
- No formal theory exists, so we build one empirically during *training* or *learning*.
- Monte Carlo experiments are run -N measurements (in the defined sense) are gathered from different viewpoints about the object of interest.

- Let *M* denote the model space.
- Through a fitting process, each measurement leads to a parametric part descriptor,  $\mathbf{m} \in M$
- The parameters of the N measurements gathered about each part,  $\{\mathbf{m}_j\}_{j=1..N}$  are used to build a sample mean,  $\mu_i$  and a sample covariance matrix,  $\mathbf{C}_i$ , for each part class  $S_i$ .

$$\mu_i = \frac{1}{N} \sum_{j=1}^{N} \mathbf{m}_j$$

$$\mathbb{C}_i = \frac{1}{N-1} \sum_{j=1}^{N} (\mathbf{m}_j - \mu_i) (\mathbf{m}_j - \mu_i)^T$$

• A concise representative distribution for each class can be built by making the following assumption:

#### Multivariate Normal Distribution:

Each object part in the database can be represented by a single multivariate normal distribution in the M parameter space.

- The validity of the assumption should be verified empirically through experimentation.
- Should the assumption prove invalid, the shape can be modified without changing the theory.

• The conditional probability density function representing the forward solution is estimated for each part in the database:

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$$p(\mathbf{m} \mid S_i) = N(\mu_i - \mathbf{m}, \mathbb{C}_i), \quad i = 1..K$$

where  $N(x, \mathbb{C})$  denotes the multivariate normal distribution with mean x and covariance  $\mathbb{C}$ .

• The process of fitting the appropriate data set to a multivariate normal distribution is repeated for each part in the database.

- In the context described, a fitting procedure takes an observed range image, **d**, and produces:
  - An estimate of the observed model parameters, m,
  - An estimate of their uncertainty represented by the covariance operator,  $C_d$ .
- The probability density function representing the measurement information:

- In the context described, a fitting procedure takes an observed range image, **d**, and produces:
  - An estimate of the observed model parameters, m,
  - An estimate of their uncertainty represented by the covariance operator,  $C_d$ .
- The probability density function representing the measurement information:  $p(\mathbf{m}|\mathbf{d})$ .

- $p(\mathbf{m}|\mathbf{d})$  measures the error in the model fitting process. It must take into account:
  - Errors in the approximation process,
  - Errors due to sensor noise.
- Direct solution difficult to obtain due to:
  - Complexity of physical process,
  - Shortage of statistically significant samples.
- Problem is ill-posed!

- We showed that we can approximate solution locally by a Gaussian distribution, whose mean,  $\hat{\mathbf{m}}$  is the maximum likelihood estimate obtained using an iterative least squares minimization based on the range data gathered.
- The result can be interpreted as a likelihood distribution, which leads to an estimate of the posterior distribution if we assume a uniform prior on model parameters,  $p(\mathbf{m})$ .

• The result is that the conditional probability density function,  $p(\mathbf{m}|\mathbf{d})$ , is represented by a multivariate normal distribution:

$$p(\mathbf{m} \mid \mathbf{d}) = N(\hat{\mathbf{m}} - \mathbf{m}, \mathbb{C}_d).$$

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There are a discrete number of part hypotheses,  $\{Si\} | i = 1..K$ . The probability density function used to represent this information, p(S):

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The probability density function used to represent this information, p(S):

$$p(S) = \sum_{i=1}^{K} p(S_i) \delta(S, S_i),$$

 $p(S_i)$  is the subjective *a priori* probability that the i<sup>th</sup> part occurs and

$$\delta(A, B) = \begin{cases} 1 & \text{for A=B.} \\ 0 & \text{otherwise.} \end{cases}$$

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We would like to compute the conditional posterior probability for each part in the database,  $p(S_i | \mathbf{d})$ :

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We would like to compute the conditional posterior probability for each part in the database,  $p(S_i | \mathbf{d})$ :

$$p(S_i | \mathbf{d}) = p(S_i) \int_{M} \frac{p(\mathbf{m} | S_i) p(\mathbf{m} | \mathbf{d})}{p(\mathbf{m})} d\mathbf{m}, \quad i = 1..K.$$

 $p(\mathbf{m})$  is the prior distribution on model parameters, assumed to be uniformly distributed. Therefore:

$$p(S_i \mid \mathbf{d}) = \frac{p(S_i)}{C} \int_{M} p(\mathbf{m} \mid S_i) p(\mathbf{m} \mid \mathbf{d}) d\mathbf{m}, \qquad i = 1..K,$$

where C is a constant.

Substituting the sources of information into the solution gives:

$$p(S_{i} | \mathbf{d}) \propto p(S_{i}) \int_{M} N(\mu_{i} - \mathbf{m}, \mathbb{C}_{i}) N(\hat{\mathbf{m}} - \mathbf{m}, \mathbb{C}_{d}) d\mathbf{m}, \quad i = 1..K,$$

$$\propto p(S_{i}) N(\hat{\mathbf{m}} - \mu_{i}, \mathbb{C}_{D_{i}}), \quad i = 1..K,$$
where  $\mathbb{C}_{D_{i}} = \mathbb{C}_{d} + \mathbb{C}_{i}$ .

Alternately, this can be expressed as:

$$p(Si \mid \mathbf{d}) \propto \sum_{i=1}^{K} p(S_i) N(\hat{\mathbf{m}} - \mu_i, \mathbb{C}_{Di}) \delta(S,S_i).$$

This results consists of a set of delta functions, one for each part in the database, where the delta is weighted by the belief in each part.

## Sequential Recognition

- The recognition problem described is difficult due to noise and uncertainties associated with each stage of the bottom-up system.
- Recognition from single viewpoints can lead to ambiguous results similar levels of belief in more than one model.

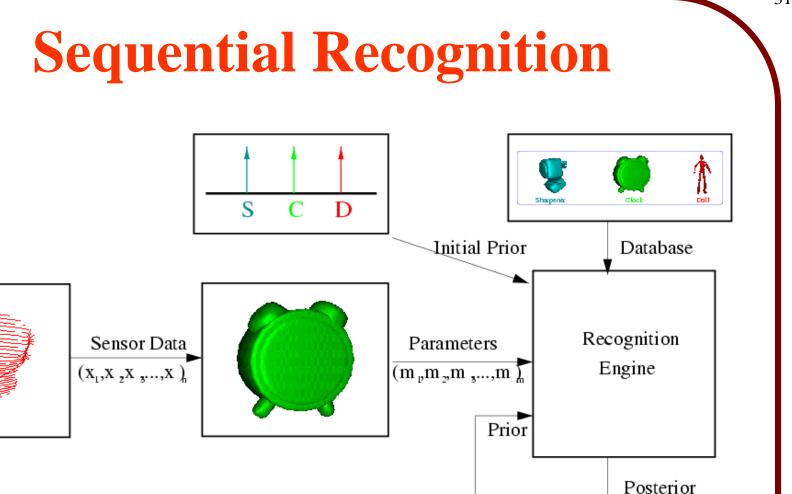
## Sequential Recognition

Following the strategy outlined before, this leads to the following updating functions for  $p(S | \mathbf{d}_{1},...,\mathbf{d}_{t+1})$ :

$$p(S \mid \mathbf{d}_{1},...,\mathbf{d}_{t+1}) \propto \sum_{i=1}^{K} p(S_i \mid \mathbf{d}_t) N(\hat{\mathbf{m}}_{t+1} - \mu_i, \mathbb{C}_{D_i}) \delta(S,S_i).$$

The idea is that ambiguities should be resolved as the data sets are gathered, leading to convergence to the correct hypothesis in a short number of iterations





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- Consider the case of a collection of object parts presented to the recognition module.
- Parts result from segmentation of 1 or more object data sets.
- Question:

Can we detect the presence of a particular part in the scene?

- Let O denote an object in a database consisting of parts  $\{S_i\}$ .
- The scene consists of a set of N measured parts resulting from the data set  $\{d\}$ .
- Goal: Decide upon the likelihood of a particular database part *S*, being among the measured scene.
- This is denoted:  $p(S|\{\mathbf{d}\})$ .

- One solution: perform recognition for each of the data sets in the scene, maintaining closed world assumption.
- Each of the data sets results in a posterior probability:  $p(S|\mathbf{d}_i)|_{i=1..N}$ .
- The likelihood of a particular database part, S, being among the measured scene can be defined as follows:

- One solution: perform recognition for each of the data sets in the scene, maintaining closed world assumption.
- Each of the data sets results in a posterior probability:  $p(S|\mathbf{d}_i)|_{i=1..N}$ .
- The likelihood of a particular database part, S, being among the measured scene can be defined as follows:

$$p(S | \{\mathbf{d}\}) = 1 - \prod_{i=1}^{N} (1 - p(S | \mathbf{d}_i)).$$

• Intuitively, this implies that the probability that the part is among the measured parts is equal to the negation of the probability that is *not* among the parts.

• Let's examine the extension to multi-part object detection:

What is the probability that object O is in the scene?

- Let *R* be the number of parts for a particular object, *O*.
- The collection of parts for O is then  $\{S_i\}|_{i=1..R}$

• The posterior probability that O is within the scene, given a collection of part measurements, is denoted:

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$$p(O | \{\mathbf{d}\}) = 1 - \prod_{i=1}^{R} (1 - p(S_i | \{\mathbf{d}\}))$$

This implies that the probability that *O* is in the scene is the negation of the probability that none of its parts are in the scene.